DECEMBER 1983-REVISED MARCH 1988

### SDLS046

Operation from Very Slow Edges

- Improved Line-Receiving Characteristics
- High Noise Immunity

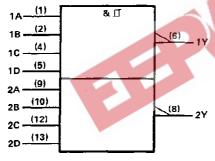
#### description

Each circuit functions as a 4-input NAND gate, but because of the Schmitt action, it has different input threshold levels for positive  $(V_{T+})$  and for negative going  $(V_{T-})$  signals.

These circuits are temperature-compensated and can be triggered from the slowest of input ramps and still give clean, jitter-free output signals.

The SN5413 and SN54LS13 are characterized for operation over the full military temperature range of  $\sim$ 55°C to 125°C. The SN7413 and SN74LS13 are characterized for operation from 0°C to 70°C.

## logic symbol†



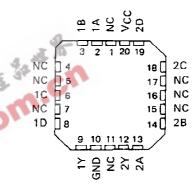
 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-13.

Pin numbers shown are for D, J, N, and W packages.

SN5413, SN54LS13...J OR W PACKAGE SN7413...N PACKAGE SN74LS13...D OR N PACKAGE (TOP VIEW)

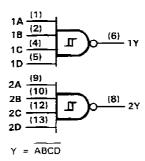
	_		
1A	П	U 14∏	Vcc
1B	$\square^2$	13	2D
NC	<b>□</b> 3	12	2C
1C	□4	11	NC
1D	Дs	10	2B
1Y	<b>□</b> 6	de	2A
GND	d۶,	8 □	2Y
-			

SN54LS13 . . . FK PACKAGE (TOP VIEW)

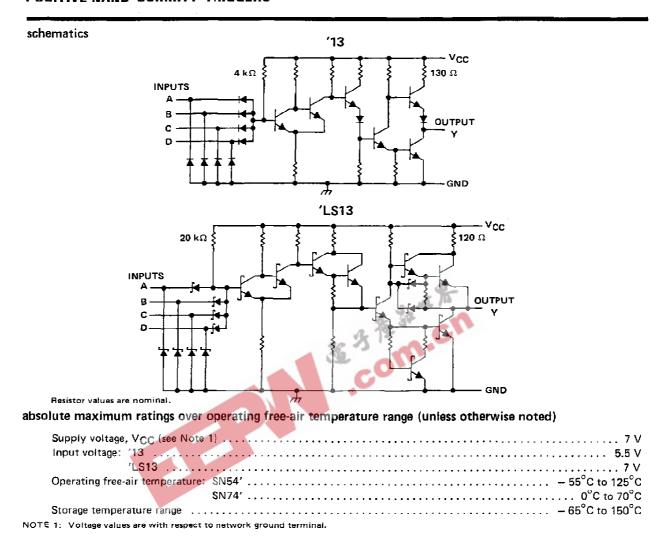


NC-No internal connection

### logic diagram (positive logic)



## SN5413, SN54LS13, SN7413, SN74LS13 DUAL 4-INPUT POSITIVE NAND SCHMITT TRIGGERS



## recommended operating conditions

		SN5413			SN7413		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC Supply voltage	4,5	5	5.5	4.75	5	5.25	V
IOH High-level output current			8.0 —			- 0.8	mΑ
IOL Low-level output current			16			16	mA
TA Operating free-air temperature	- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TI	ST CONDITIONS†	· · · · · · · · · · · · · · · · · · ·		MIN	TYP#	MAX	UNIT
V <sub>T+</sub>	V <sub>CC</sub> = 5 V					1,5	1.7	2	V
ν <sub>T</sub>	V <sub>CC</sub> = 5 V					0.6	0.9	1.1	V
Hysteresis (V <sub>T+</sub> -V <sub>T-</sub> )	V <sub>CC</sub> = 5 V					0.4	0.8		٧
VIK	V <sub>CC</sub> = MIN,	I <sub>1</sub> = - 12 mA				1		<b>- 1.5</b>	V
Voн	V <sub>CC</sub> = MIN,	V <sub>1</sub> = 0.6 V,	I <sub>QH</sub> = - 0,8 mA			2.4	3,4		V
VOL	VCC = MIN,	V <sub>1</sub> = 2 V,	I <sub>OL</sub> = 16 mA		- A3		0.2	0.4	V
IT+	V <sub>CC</sub> = 5 V,	V! = VT+			五月	T	- 0.65	_	mΑ
<sup>1</sup> T-	V <sub>CC</sub> = 5 V,	V <sub>I</sub> = V <sub>T</sub> _		- %			- 0.85		mA
11	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 5,5 V		18 de			***************************************	1	mA
ЦН	V <sub>CC</sub> = MAX,	VIH = 2.4 V	42	2 23 1				40	μА
HL	V <sub>CC</sub> = MAX,	V <sub>IL</sub> = 0.4 V		2			- 1	- 1.6	mA
IOS §	VCC = MAX,			100		- 18		- 55	mΑ
ГССН	V <sub>CC</sub> = MAX	-					14	23	mA
<sup>I</sup> CCL	VCC = MAX						20	32	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS			TYP	MAX	UNIT
tp∟H	Anv	γ	R <sub>1</sub> = 400 Ω,	C <sub>1</sub> = 15 pF		18	27	ns
tPHL	,	•	700 32,	OL .0P.		15	22	ns

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ} \text{ C}$ . § Not more than one output should be shorted at a time.

## SN54LS13, SN74LS13 **DUAL 4-INPUT** POSITIVE NAND SCHMITT TRIGGERS

### recommended operating conditions

	s	SN54LS13 SN74LS13			13		
	MIN	MOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	V
IOH High-level output current			- 0.4			0.4	mA
OL Low-level output current			4			8	mΑ
TA Operating free-air temperature	- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER TEST CONDITIONS		••	9	N54LS1	13		UNIT			
PARAMETER	LEST CONDITIONS.				MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VT÷	V <sub>CC</sub> = 5 V				1.4	1,6	1.9	1.4	1.6	1.9	V
V <sub>T</sub> _	V <sub>CC</sub> = 5 V				0,5	0,8	1	0.5	0.8	1	V
Hysteresis (V <sub>T+</sub> –V <sub>T</sub> _)	V <sub>CC</sub> = 5 V	-			0.4	0,8		0.4	0.8		V
Vik	V <sub>CC</sub> = MIN,	I <sub>I</sub> = - 18 mA					1.5			1.5	V
∨он	V <sub>CC</sub> = MIN,	V <sub>I</sub> = 0.5 V,	l <sub>OH</sub> = − 0,4 m	nA	2.5	3.4		2.7	3.4		V
			-	I <sub>OL</sub> ≈ 4 mA		0.25	0.4		0.25	0.4	l
V <sub>OL</sub>	V <sub>CC</sub> = MIN,	V <sub>1</sub> = 1.9 V		IOL = 8 mA	70	d			0.35	0.5	<b>V</b>
ŀT+	V <sub>CC</sub> = 5 V,	V <sub>1</sub> = V <sub>T+</sub>		几份	-	- 0.14	1		- 0.14	•	mA
I <sub>T</sub>	V <sub>CC</sub> = 5 V,	V1 = VT_		26 13	A Common	- 0.18			- 0.18		mΑ
	V <sub>CC</sub> = MAX,	v <sub>1</sub> = 7 v		132	14.		0.1			0.1	mΑ
lн	V <sub>CC</sub> = MAX,	V <sub>IH</sub> = 2.7 V					20			20	μА
ll.	V <sub>CC</sub> = MAX,	VIL = 0.4 V		-			- 0.4			- 0.4	mΑ
los 🤅	V <sub>CC</sub> = MAX				- 20		- 100	- 20		- 1 <b>0</b> 0	mΑ
1ссн	V <sub>CC</sub> = MAX					2.9	6		2,9	6	mΑ
ICCL	Vcc = MAX				l	4.1	7		4.1	7	mΑ

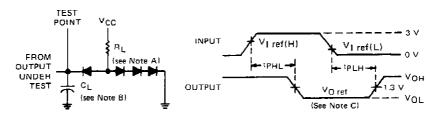
<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	MIN	TYP	MAX	UNIT	
tpLH	Any	¥	$R_1 = 2 k\Omega$ ,	C <sub>L</sub> = 15 pF		15	22	กร
tPHL	- City	·	11 2 1125,	OL 1391		18	27	ns

<sup>‡</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. § Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

## PARAMETER MEASUREMENT INFORMATION



#### LOAD CIRCUIT

**VOLTAGE WAVEFORMS** 

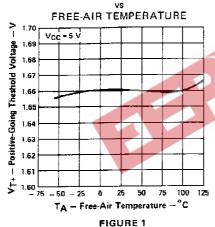
NOTES: A. All diodes are 1N3064 or equivalent.

- B. C<sub>L</sub> includes probe and jig capacitance.
- C. Generator characteristics and reference voltages are:

	Generator Characteristics				Reference Voltages				
]	Zout	PRR	t <sub>r</sub>	tę	Viref(H)	V <sub>1 ref(L)</sub>	VO ref		
SN54'/SN74'	50 Ω	1 MHz	10 ns	10 ns	1.7 V	0.9 V	1.5 V		
SN54LS'/SN74LS'	<b>50</b> Ω	1 MHz	15 ns	6 ns	1.6 V		1,3 ∨		

## TYPICAL CHARACTERISTICS OF '13 CIRCUITS





## NEGATIVE-GOING THRESHOLD VOLTAGE

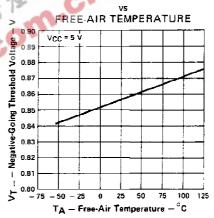


FIGURE 2

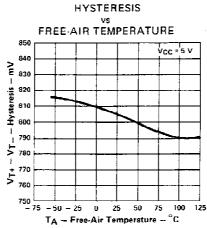
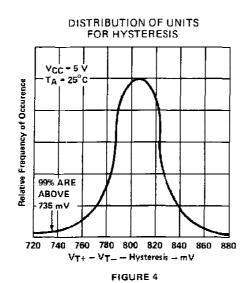
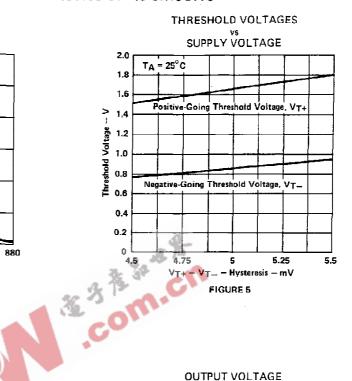


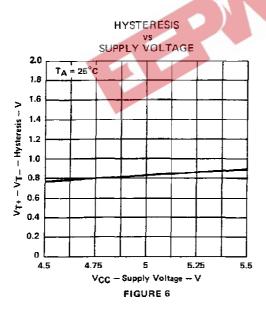
FIGURE 3

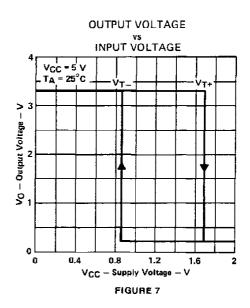
Data for temperatures below  $0^{\circ}$ C and  $70^{\circ}$ C and supply voltages below 4.75 V and above 5.25 V are applicable for \$N5413 only.

### **TYPICAL CHARACTERISTICS OF '13 CIRCUITS**







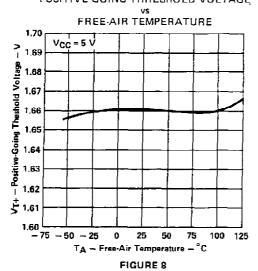


Data for temperatures below  $0^{\circ}$  C and  $70^{\circ}$  C and supply voltages below 4.75 V and above 5.25 V are applicable for SN5413 only.

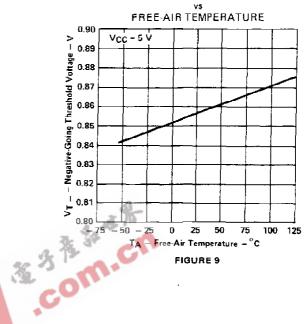


#### TYPICAL CHARACTERISTICS OF 'LS13 CIRCUITS

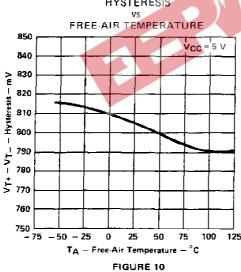




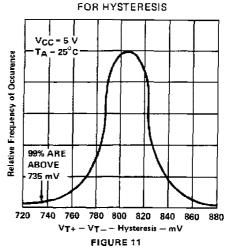
### NEGATIVE-GOING THRESHOLD VOLTAGE



## HYSTERESIS

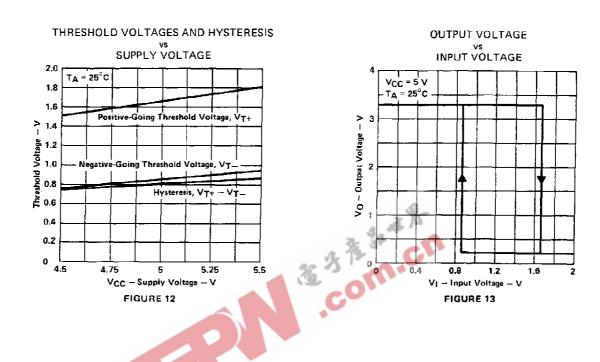


# DISTRIBUTION OF UNITS



Data for temperatures below 0°C and above 70°C and supply voltages below 4.75 V and above 5.25 V are applicable for SN54LS13 only.

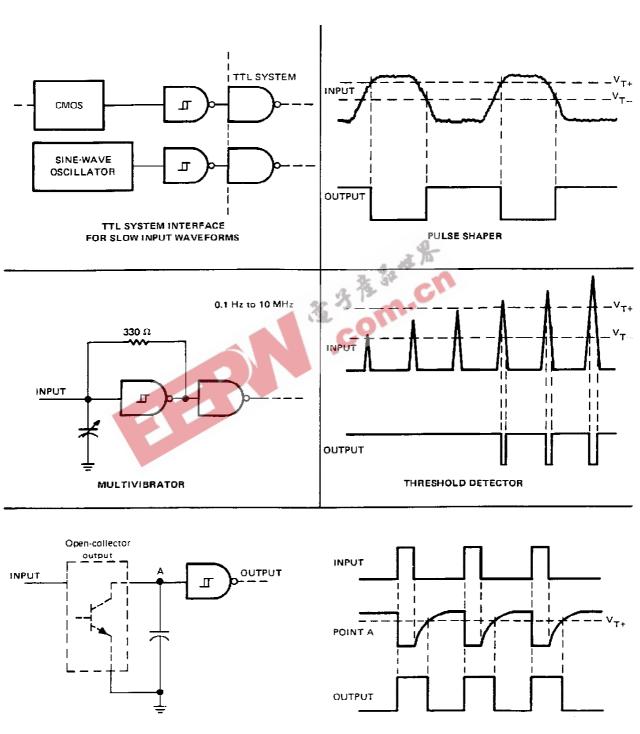
#### TYPICAL CHARACTERISTICS OF 'LS13 CIRCUITS



Data for temperatures below  $0^{\circ}$  C and above  $70^{\circ}$  C and supply voltages below 4.75 V and above 5.25 V are applicable for SN54LS13 only.



## TYPICAL APPLICATION DATA







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